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Neporušitvene preiskave - Preskušanje z ultrazvokom - Slovar (ISO/DIS 5577:2024)

Non-destructive testing - Ultrasonic testing - Vocabulary (ISO/DIS 5577:2024)

Zerstörungsfreie Prüfung - Ultraschallprüfung - Begriffe (ISO/DIS 5577:2024)

Essais non destructifs - Contrôle par ultrasons - Vocabulaire (ISO/DIS 5577:2024)

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Non-destructive testing — Ultrasonic testing — Vocabulary

Essais non destructifs — Contrôle par ultrasons — Vocabulaire

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Foreword

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The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular, the different approval criteria needed for the different types of ISO documents should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2 (see www.iso.org/directives).

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For an explanation of the voluntary nature of standards, the meaning of ISO specific terms and expressions related to conformity assessment, as well as information about ISO's adherence to the World Trade Organization (WTO) principles in the Technical Barriers to Trade (TBT), see www.iso.org/iso/foreword.html.

This document was prepared by Technical Committee ISO/TC 135, *Non-destructive testing*, Subcommittee SC 3, *Ultrasonic testing*.

This third edition cancels and replaces the second edition (ISO 5577:2017), which has been technically revised.

The main changes are as follows:

- terms pulse overshoot, main lobe, main beam, side lobe, diffraction, contact surface, echo amplitude, signal amplitude, full screen height were added,
- the term plate wave was replaced by Lamb wave,
- some definitions were modified.

Any feedback or questions on this document should be directed to the user's national standards body. A complete listing of these bodies can be found at www.iso.org/members.html.

Non-destructive testing — Ultrasonic testing — Vocabulary

1 Scope

This document defines the terms used in ultrasonic non-destructive testing and forms a common basis for standards and general use.

This document does not cover specific terms used in ultrasonic testing with arrays.

NOTE Terms used in ultrasonic testing with arrays are defined in ISO 23243.

2 Normative references

There are no normative references in this document.

3 Terms and definitions

For the purposes of this document, the terms and definitions given in [Clauses 4, 5, 6 and 7](#) for sound, test equipment and ultrasonic testing apply.

ISO and IEC maintain terminology databases for use in standardization at the following addresses:

- ISO Online browsing platform: available at <https://www.iso.org/obp>
- IEC Electropedia: available at <https://www.electropedia.org/>

4 Terms and definitions related to frequencies, waves and pulses

4.1 Frequencies

4.1.1

frequency

number of cycles per second

Note 1 to entry: Expressed in Hertz (Hz).

4.1.2

nominal frequency

probe frequency

frequency ([4.1.1](#)) of the *probe* ([6.2.1](#)) as stated by the manufacturer

4.1.3

test frequency

effective ultrasonic frequency of a system used to test a material or object

4.1.4

frequency spectrum

distribution of *amplitude* ([4.2.2](#)) in relation to *frequency* ([4.1.1](#))

Note 1 to entry: See [Figure 1](#).

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4.1.5**centre frequency**

arithmetic mean of the upper and lower cut-off frequencies

Note 1 to entry: See [Figure 1](#).

4.1.6**peak frequency**

frequency ([4.1.1](#)) at which the maximum amplitude is observed

Note 1 to entry: See [Figure 1](#).

4.1.7**cut-off frequency**

frequency ([4.1.1](#)) at which the *amplitude* ([4.2.2](#)) of the transmitted signal has dropped by a specified amount from the amplitude at *peak frequency* ([4.1.6](#)), for example, by 3 dB

Note 1 to entry: See [Figure 1](#).

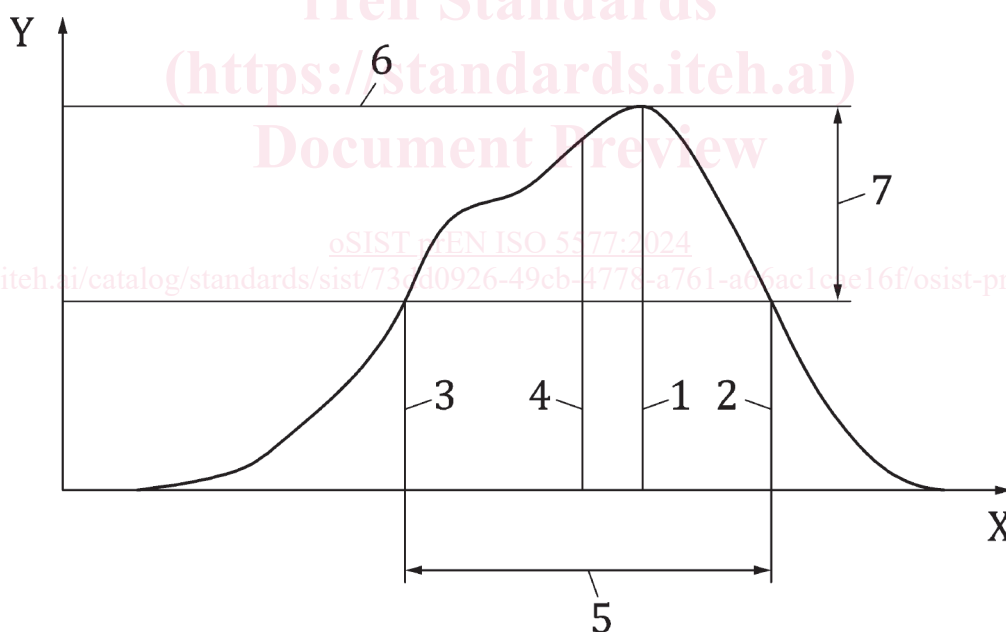
4.1.8**bandwidth**

width of the *frequency spectrum* ([4.1.4](#)) between the upper and lower cut-off frequency

Note 1 to entry: See [Figure 1](#).

4.1.9**relative bandwidth**

ratio of the *bandwidth* ([4.1.8](#)) to the *centre frequency* ([4.1.5](#)), in per cent

**Key**

X	frequency	4	centre frequency
Y	amplitude	5	bandwidth at specified amplitude drop
1	peak frequency	6	peak amplitude
2	upper cut-off frequency	7	specified amplitude drop
3	lower cut-off frequency		

Figure 1 — Frequency spectrum and related terms

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4.2 Waves and pulses

4.2.1

ultrasonic wave

any acoustic wave having a *frequency* (4.1.1) higher than the audible range of the human ear, generally taken as higher than 20 kHz

4.2.2

amplitude

absolute or relative measure of a sound wave's momentary magnitude

Note 1 to entry: The amplitude is not necessarily the maximum value, see *echo amplitude* (7.5.6).

4.2.3

phase

momentary condition of a vibration expressed as an arc measurement or an angle

4.2.4

wavelength

distance along the propagating direction between consecutive corresponding points of the same *phase* (4.2.3)

Note 1 to entry: See [Figure 2](#).

4.2.5

wavefront

continuous surface joining all the most forward points of an *ultrasonic wave* (4.2.1) that have the same *phase* (4.2.3)

4.2.6

time of flight

TOF

time it takes an ultrasonic pulse to travel from the transmitter probe through the *test object* (7.2.2) to the receiver probe

4.2.7

pulse

electrical or ultrasonic signal of short duration

4.2.8

pulse amplitude

maximum amplitude of a *pulse* (4.2.7) (peak-to-peak)

Note 1 to entry: For rectified pulses (A-scan), baseline-to-peak.

4.2.9

pulse rise time

time taken for a *pulse amplitude* to change from a specified lower level to a specified upper level

4.2.10

pulse duration

time interval between the leading and trailing edges of a *pulse* (4.2.7) measured at a specified level below the peak amplitude

4.2.11

pulse shape

diagramatic representation of the *amplitude* (4.2.2) of a *pulse* (4.2.7) as a function of time

4.2.12

pulse envelope

contour of a *pulse shape* (4.2.11) including all the peaks in terms of *amplitude* (4.2.2) and time

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4.2.13

pulse energy

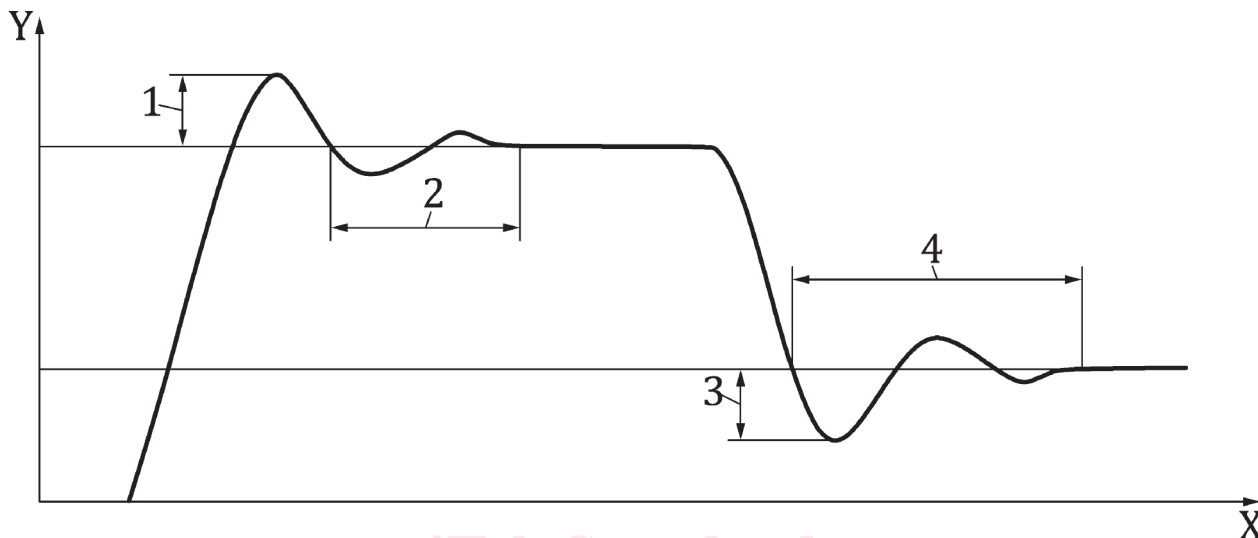
total energy within a *pulse* (4.2.7)

4.2.14

pulse overshoot

undesirable voltage peak at the rising or falling edge of a *pulse* (4.2.7)

Note 1 to entry: See [Figure 2](#).

**Key**

X time

Y amplitude

1 pulse overshoot at raising edge

2 pulse reverberation at raising edge

3 pulse overshoot at falling edge

4 pulse reverberation at falling edge

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Figure 2 — Pulse overshoot and pulse reverberation

4.2.15

pulse reverberation

vibration time after the rising or the falling edge of a *pulse* (4.2.7)

Note 1 to entry: See [Figure 2](#).

4.2.16

broad-band pulse

pulse (4.2.7) in which the *relative bandwidth* (4.1.9) is $\geq 65\%$

4.2.17

medium-band pulse

pulse (4.2.7) in which the *relative bandwidth* (4.1.9) is $>35\%$ and $<65\%$

4.2.18

narrow-band pulse

pulse (4.2.7) in which the *relative bandwidth* (4.1.9) is $\leq 35\%$

ISO/DIS 5577:2024(en)**4.2.19****pulse repetition frequency****PRF**

number of *transmitter pulses* (6.1.3) generated per second, expressed in Hertz (Hz)

4.3 Types of ultrasonic waves**4.3.1****longitudinal wave**

compression wave

wave in which the direction of displacement of particles is in the same direction as the propagation of the wave

Note 1 to entry: See [Figure 3 a](#)).

4.3.2**transverse wave**

shear wave

wave in which the direction of displacement of particles is perpendicular to the direction of the propagation of the wave

Note 1 to entry: See [Figure 3 b](#)).

4.3.3**Rayleigh wave**

surface wave

wave which propagates on the surface of a test object with an effective penetration depth of less than one *wavelength* (4.2.4)

4.3.4**creeping wave**

wave generated around the first critical angle of incidence and propagating along the surface like a longitudinal wave with a slightly lower velocity than the longitudinal wave, interacting with the surface and partially transforming into a transverse wave going into the volume of the test object

Note 1 to entry: It is neither influenced by the test object's surface conditions, nor does the wave follow undulations on the surface.

4.3.5**Lamb wave**

wave which propagates within the whole thickness of a plate and which can only be generated at particular values of angle of incidence, *frequency* (4.1.1) and plate thickness

4.3.6**plane wave**

wave with a planar wave front

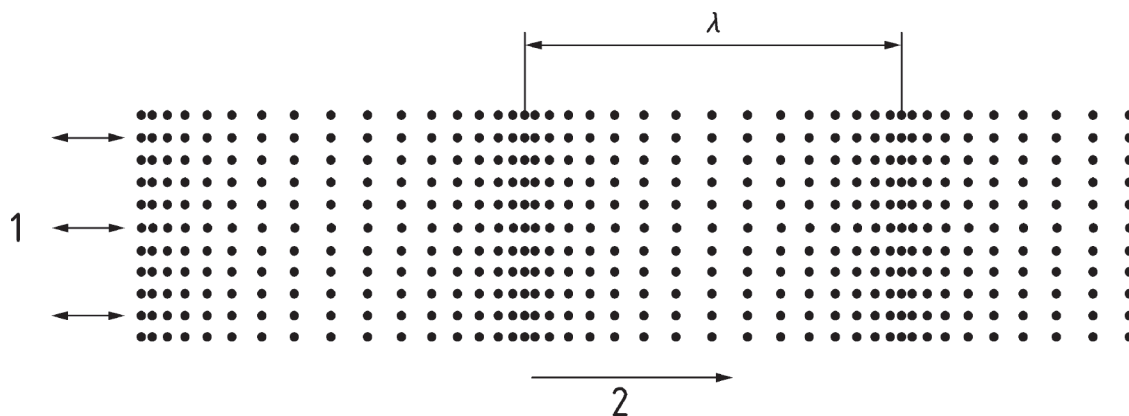
4.3.7**cylindrical wave**

wave with a cylindrical wave front

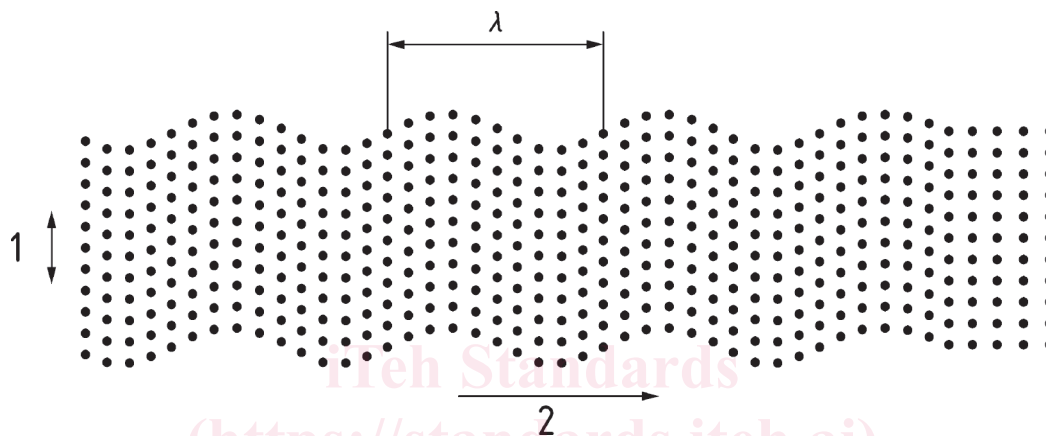
4.3.8**spherical wave**

wave with a spherical wave front

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a) Longitudinal wave; compression wave



b) Transverse wave; shear wave

Key

- 1 direction of oscillation
- 2 direction of propagation
- λ wavelength

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Figure 3 — Types of waves**5 Terms related to sound****5.1 Sound generation and reception****5.1.1****transducer**

active element of a *probe* (6.2.1) which converts electrical energy into sound energy and vice versa

5.1.2**piezoelectric transducer**

transducer (5.1.1) made from piezoelectric material

Note 1 to entry: Because the first piezoelectric transducers were cut from a quartz crystal, up to now transducers often misleadingly are called crystals.

5.1.3**composite transducer**

plate consisting of piezoelectric ceramic rods embedded in a polymer matrix